

83023

8/181/60/002/008/042/045

B006/B063

Determination of the Recombination Constants  
 and the Depth of the Position of the p-n  
 Junction From the Spectral Characteristics of Photocells

( $j_{s.c.}$  - short-circuit current density,  $D_p$  - hole diffusion coefficient  
 in the n-type region,  $q$  - electron charge,  $L_p$  - diffusion length of the

minority carriers in the n-type region,  
 $l_n$  - thickness of the n-type region,  
 $L_n$  - diffusion length of the minority  
 carriers in the p-type region,  $l_p$  - thick-  
 ness of the p-type region,  $s$  - rate of sur-  
 face recombination on the n-type surface,  
 $H$  - quantum flux density). Thus, for  
 example, for  $l_n/L_p \gg 1$ :

$$L_p = (h_1 - h_2) / (h_2/a_2 - h_1/a_1), \text{ and for}$$

$l_n/L_p \ll 1 : l_n = (h_1 - h_2) / (h_2/a_2 - h_1/a_1)$ . If the ratio between the short-  
 circuit current densities of the two wavelengths is denoted by  $\alpha$ , the  
 following relation is valid:

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Determination of the Recombination Constants      S/181/60/002/008/042/045  
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$s/D_p = (\alpha - 1)k_1/(1 - \frac{k_1}{k_2}\alpha)$ . The above relations for  $L_p$  and  $I_n$  may also be given for one wavelength,  $\lambda$ , if the sample has two different values for  $s$ . Here,  $\alpha'$  denotes the ratio between the short-circuit current densities, and  $w = (1 + \frac{s_2}{D_p} \frac{1}{k})/(1 + \frac{s_1}{D_p} \frac{1}{k})$ .

$$\frac{I_n}{L_p} \gg 1 : L_p = (1 - \alpha'w)/(\alpha'w \frac{s_1}{D_p} - \frac{s_2}{D_p});$$

$$\frac{I_n}{L_p} \ll 1 : I_n = (1 - \alpha'w)/(\alpha'w \frac{s_1}{D_p} - \frac{s_2}{D_p}).$$

There are 1 figure and 3 Soviet references.

ASSOCIATION: Institut poluprovodnikov AN SSSR Leningrad (Institute of Semiconductors of the AS USSR, Leningrad)

SUBMITTED: February 3, 1960

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9,4160  
26.2421

23096  
S/181/61/003/005/001/042  
B101/B214

AUTHOR: Dubrovskiy, G. B.

TITLE: The optical properties of CdTe

PERIODICAL: Fizika tverdogo tela, v. 3, no. 5, 1961, 1305-1309

TEXT: CdTe is considered a promising material for the conversion of solar energy into electrical and for use as indicators of x-rays and ultra-violet rays. This was the reason for undertaking the work presented in this paper: measurement of the absorption and reflection coefficients of CdTe in the range 0.4-6.0  $\mu$  of the refractive index in the vicinity of the limit of the self-absorption, and of the forbidden band width. A) Absorption coefficient: The measurements were made on 0.05-2 mm thick plane parallel plates of CdTe ( $\alpha = 930 \text{ } \mu\text{v/deg; } \sigma \approx 4 \cdot 10^{-5} \text{ ohm}^{-1} \text{ cm}^{-1}$ ), and on layers sputtered on quartz in vacuum. The x-ray structure analysis confirmed that such layers showed no deviation from the normal crystal structure of CdTe. The multiple reflection was taken into account in the range of weak absorption ( $k < 50 \text{ cm}^{-1}$ ) and the absorption coefficient was calculated from the equation:

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$$\frac{\sqrt{\frac{I_o}{I_d} (1-r)^2 + 4r^2 - \frac{I_o}{I_d} (1-r)^2}}{2r} \quad (1),$$

where  $k$  = absorption coefficient,  $I_o$  = intensity of the incident light,  
 $r$  = reflection coefficient,  $I_d$  = intensity of the light transmitted through  
the sample, and  $d$  = thickness of the sample. For  $k > 50 \text{ cm}^{-1}$  this equation  
goes over in:  $\exp(-kd) = I_d/I_o(1-r)^2$  (2). The measurements at

$k < 100 \text{ cm}^{-1}$  were made with the help of ZMP-2 (ZMR-2) monochromator with  
recorder. In the range  $k > 100 \text{ cm}^{-1}$  the monochromatic light beam was once  
again split up in the VGT-65 (ISP-65) spectrograph in order to remove the  
scattered light and to separate the luminescence observed at short waves  
(maximum at  $0.9\text{-}1.0 \mu$ ). The sources of light were: a 17 v, 170 w tungsten  
lamp, an HKP (IKR) pin, or a high-pressure mercury lamp of the type CSAM-1000  
(SVDSH-1000). The transmitted light was measured by a bolometer, PBS  
photoresistance, Sb - Ca photoelement, or by means of a photographic plate  
and previously introduced neutral filters (when a two piece spectral appara-  
tus is used). The results are shown in Fig. 1. B) Reflection coefficient:

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This was measured for the same samples. The total reflection was measured by means of an  $\text{mC}\ddot{\text{o}}\text{-2M}$  (SF-2M) spectrophotometer in the range  $0.4\text{-}0.7 \mu$ , and the reflected component was measured in the range  $0.7\text{-}6.0 \mu$  by means of a ZMR-2 monochromator. The results are shown in Fig. 2. C) The refractive index was measured in the range of transmission by means of a continuously variable light wave (Fig. 3). It was calculated from the interference effect by means of the formula  $2dn = N\lambda$ , where  $d$  = thickness of the sample,  $n$  = refractive index,  $N$  = ordinal number of interference. It was found that  $n = 3.27 \pm 0.05$  in the range  $1.0\text{-}1.3 \mu$ . From the formula  $\epsilon = n^2$  the dielectric constant was found to be  $10.7 \pm 0.3$ . D) The forbidden band width was found to be 1.45 ev from the function  $k = f(h\nu)$ . The course of the curve  $k^{1/2} = f(h\nu)$  observed by G. G. Macfarlane and V. Roberts (Ref. 10, see below) for Ge and Si does not hold for CdTe. As shown in Fig. 4,  $k^{1/2} = f(h\nu)$  has only one linear part. The curve is distorted for lower  $k$  values, the distortion being explained as due to absorption at impurity levels. The impurity level was determined by measuring the impurity photo-emf on the p-n junction formed due to the occurrence of a p-type film in air.

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The measurement was made by 1) fusion of indium on the n-type side, and 2) pressing a copper ring on the p-type side, (Fig. 5a). If a metal layer is laid on the exposed side to improve sensitivity, two maxima of the photo-current are obtained (Fig. 5b). The second maximum at 1.2 ev is explained as being due to the diffusion of the metal into the sample and formation of new impurity centers. The curve of Fig. 5b is obtained after a slight heating of the specimens. The discussion of the data led to the following conclusions: 1) The small photo-emf is due to small thickness of the p-type layer ( $10^{-5}$  cm) and low absorption coefficients ( $< 0.05 \text{ cm}^{-1}$ ). 2) The maxima of the photo-emf in Fig. 5b correspond to two impurity levels at distances  $0.15 \pm 0.05$  and  $0.25 \pm 0.05$  ev from the bottom of the forbidden band. The level 0.15 ev is explained as due to the absorption of light at the impurity level  $V_{\text{Cd}}$ . In order to determine the absorption coefficients as a function of the photo-energy, measurements have to be made in vacuum because a layer deficient in Cd is formed on the surface of the CdTe. Professor Yu. P. Maslakovets is thanked for discussions. There are 5 figures and 13 references: 4 Soviet-bloc and 9 non-Soviet-bloc. The 4 most recent references to English-language publications read as follows:

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S/181/61/003/005/C01/042  
B101/B214

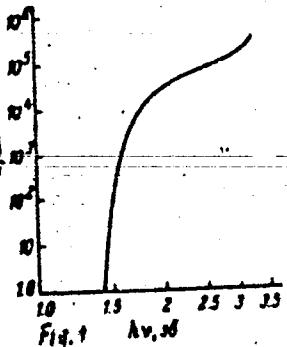
The optical properties ...

G. O. Macfarlane and V. Roberts, Phys. Rev., 98, 6, 1955; ibid., 97, 6, 1955; R. Braunstein, A. R. Moore, and P. Herman, Phys. Rev. 109, 3, 1958; D. de Nobel, Philips Res. Rep., 14, 4, 1959.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors, AS USSR, Leningrad)

SUBMITTED: November 4, 1960

Fig. 1: Light absorption coefficient  $\kappa$  as a function of  $h\nu$  for CdTe

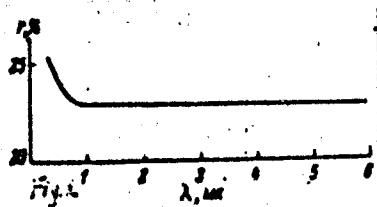


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s/181/61/003/005/001/042  
B101/B214

The optical properties ...

Fig. 2: Reflection coefficient  
r as a function of the wave-  
length

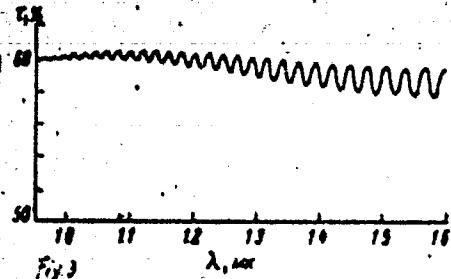


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S/181/61/003/005/001/042  
B101/B214

The optical properties ...

Fig. 3: Interference effect obtained by measuring the transmission of light through a thin sample of CdTe



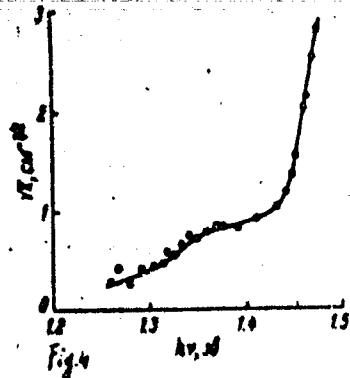
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9/181/61/003/005/001/042  
B101/B214

The optical properties ...

Fig. 4:  $k^{1/2} = f(h\nu)$  for  
CdTe



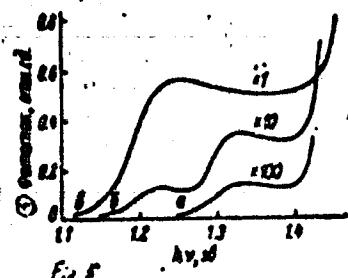
Card 8/9

S/181/61/003/005/001/042  
B101/B214

The optical properties ...

Fig. 5: Photocurrent in CdTe samples with p-n type junction as a function of  $h\nu$ .

Legend: (1) Photocurrent in relative units



Card 9/9

DUBROVSKII, G.B.

Methods of spectral characteristics for the determination of basic  
parameters of photocells with the p-n junction. Zav.lab. 27  
no.10:1233-1236 '61. (MIRA 14:10)

1. Institut poluprovodnikov AN SSSR.  
(Photoelectric cells—Spectra)

24.75D

13108  
S/181/62/004/011/003/049  
B102/B104

AUTHORS: Dubrovskiy, G. B., and Subashiyev, V. K.

TITLE: The effect of high alloying on the selfabsorption edge in silicon

PERIODICAL: Fizika tverdogo tela, v. 4, no. 11, 1962, 3018 - 3026

TEXT: Silicon single crystals doped with boron by means of diffusion up to boron concentrations of  $6 \cdot 10^{20} \text{ cm}^{-3}$ , a value close to the solubility limit, were used to investigate the position of the selfabsorption edge in dependence on the boron concentration. Specimens 9-13  $\mu$  thick, measuring 5.5 mm, were cut from doped crystals of about 1 mm thickness at various boron concentrations and were then ground. Differences in the concentration along the surface of these layers were determined. In a layer of 13.5  $\mu$  thickness, the concentrations worked out at  $7.2 \cdot 10^{19}$  and  $9.4 \cdot 10^{19} \text{ cm}^{-3}$ . The transmission and reflection of monochromatic (0.6-2.0ev) light were measured by the usual method. All measurements were made at room temperature, and in some cases down to - 150°C. Results: Light absorption Card 1/4

S/181/62/004/011/003/049

B102/B104

The effect of high ...

by free carriers satisfies the law  $\alpha_c \sim \lambda^2$ . When the hole concentration changes from  $10^{13}$  to  $10^{20} \text{ cm}^{-3}$  the edge of the fundamental absorption band is shifted by ~0.03 ev toward higher energies, i. e., the forbidden band is somewhat broadened. The thermal broadening coefficient of the forbidden band, determined from the curves  $\alpha_{self} = f(h\nu)$ , was  $\sim 4 \cdot 10^{-4} \text{ ev}/^\circ\text{C}$ , which is the same value as for pure Si. The change of the minimum energy occasioned by indirect transmission into doped silicon,  $\Delta E_{ga}$ , may be due to various effects: Fermi degeneracy of the valence band ( $\Delta E_{gf}$ ), action of the Coulomb field of the impurity ions ( $\Delta E_{ga}$ ), changes in the lattice constant ( $\Delta E_{ga}$ ). Evaluations gave:  $\Delta E_{gf} \approx +0.20 \text{ ev}$  at a hole concentration of  $2 \cdot 10^{20} \text{ cm}^{-3}$ ;  $\Delta E_{ga} \approx -5 \cdot 10^{-5} \text{ ev}$ ;  $E_g C$  cannot be evaluated quantitatively but is likely to be positive. An appendix deals with the calculation of the absorption coefficient  $\alpha$  from measurements of light transmission and reflection. There are 4 figures.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors AS USSR, Leningrad)

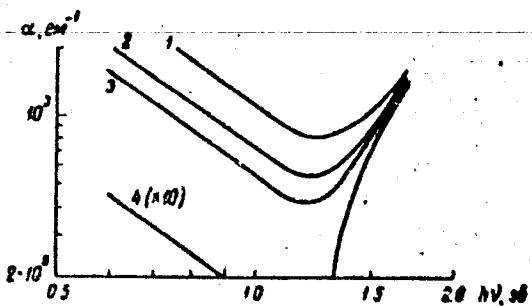
Card 2/4

The effect of high ...

8/181/62/004/011/003/049  
B102/B104

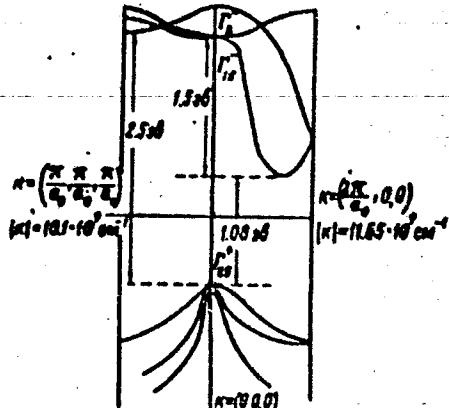
SUBMITTED: April 28, 1962

Fig. 1:  $\alpha = f(h\nu)$  for  $p = 2 \cdot 10^{20} \text{ cm}^{-3}$   
 (1),  $1.3 \cdot 10^{20} \text{ cm}^{-3}$  (2),  $9.7 \cdot 10^{19} \text{ cm}^{-3}$   
 (3) and  $2.8 \cdot 10^{18} \text{ cm}^{-3}$  (4).



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Fig. 4. Silicon band structure  
( $3\Delta = 1.165 \text{ eV}$ ).



S/181/63/005/003/041/046  
B102/B180

AUTHOR: Dubrovskiy, G. B.

TITLE: Dependence of the forbidden-band width of  $\text{InP}_{x}\text{As}_{1-x}$ -compounds  
on composition

PERIODICAL: Fizika tverdogo tela, v. 5, no. 3, 1963, 954-955

TEXT:  $E_g$  the forbidden band width of  $\text{InP}_{x}\text{As}_{1-x}$  with  $0 \leq x \leq 1.0$  was determined from measurements of the fundamental absorption band edges, by linearly extrapolating the transmission curves (transmission as a function of  $\lambda$ ) to 100% transmission (error 0.03 ev). The values obtained for  $E_g$  were plotted versus  $x$  and  $E_g$  was found to increase linearly with  $x$  from ~0.4 ev ( $x=0$ ) to ~1.3 ev ( $x=1.0$ ). There are 2 figures.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad  
(Institute of Semiconductors AS USSR, Leningrad)

"APPROVED FOR RELEASE: 08/25/2000

**CIA-RDP86-00513R000411420003-6**

SECTION DEAKS. THE CONGREGATION IS THE LEADERSHIP IN THIS SECTION.

APPROVED FOR RELEASE: 08/25/2000      CIA-RDP86-00513R000411420003-6"

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

APPROVED FOR RELEASE: 08/25/2000 CIA-RDP86-00513R000411420003-6"

ACCESSION NO: AP4004857

S/0181/63/005/012/3361/3366

AUTHOR: Dubrovskiy, G. B.

TITLE: Absorption energy spectrum near main band edge in heavily doped Ge and Si

SOURCE: Fizika tverdogo tela, v. 5, no. 12, 1963, 3361-3366

TOPIC TAGS: germanium, silicon, direct transition, absorption edge, main absorption edge, transition energy spectrum, transition energy, absorption band

ABSTRACT: The edge of the main absorption band in Ge and Si is determined by indirect transitions of electrons from the valence band to the conduction band. These transitions take place with change in the wave vector of the electrons, but scattering at lattice vibrations or impurities may give insufficient impulse to the electrons. For pure metals the principal mechanism of scattering is clearly scattering by phonons. In strongly doped specimens there may be a change in the shape of the band edge because of the increasing role of the impurity mechanism of scattering and of the Fermi degeneracy of one of the bands. The author has examined the energy spectra of direct and indirect transitions in strongly doped Ge and Si, considering the deviation of the law of electron dispersion in the valence band

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ACCESSION NO: AP4004837

(from the quadratic law). For p-type Ge, the displacement of the edge of direct transition, when the valence band is degenerate, is approximately 10 times the Fermi energy of degeneracy. In degenerate n-type Ge, the displacement of the band edge is almost equal to the Fermi energy in the conduction band, since the energy of an electron in the conduction band is almost equal to the energy of a photon in excess of the width of the forbidden band. The author discusses ways of treating experimental data on the edge of the main absorption band which will permit one to determine the energy dependence for the probability of direct transition and the degree of deviation of the valence band from a parabolic form. "The author thanks B. Ya. Moyzhes and V. K. Subashiyev for their numerous useful discussions on this question." Orig. art. has: 4 figures and 20 formulas.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors AN SSSR)

SUBMITTED: 11May63

DATE ACQ: 05Jan64

ENCL: 00

SUB CODE: PH

NO REF Sov: 003

OTHER: 009

Card 2/2

ACCESSION NR: AP4013515

S/0181/U/006/002/0512/0514

AUTHORS: Subashiyev, V. K.; Dubrovskiy, G. B.

TITLE: Quantum yield of the internal photoelectric effect in highly doped semiconductors

SOURCE: Fizika tverdogo tela, v. 6, no. 2, 1964, 512-514

TOPIC TAGS: quantum yield, photoelectric effect, photoactive absorption, nonphotoactive absorption, current carrier absorption

ABSTRACT: In some frequency range immediately next the edge of the principal absorption band, a continuous change in quantum yield is observed, from 0 to 1. This range narrows as temperature declines. If electrons are excited from the valence band to the conduction band by a single mechanism of light absorption, then at absolute zero the energy dependence of the quantum yield should exhibit a clear "step" at  $h\nu = E_g$ . It is shown that when nonphotoactive absorption is present, the quantum yield is expressed by the coefficients of absorption in the following form:  $\beta = \frac{a_p}{a_p + a_n}$ , where  $a_p$  and  $a_n$  are the coefficients of photo-

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ACCESSION NR: AP4013515

active and nonphotoactive absorption, respectively. It has been found that through a wide spectral range the coefficient of nonphotoactive absorption may be equal to or even considerably larger than that of photoactive absorption, and this, of course, leads to a decrease in quantum yield. In highly doped materials, the principal mechanism of nonphotoactive absorption is absorption by free current carriers. "The authors express their sincere thanks to N. S. Zhdanovich for his great aid in treating the experimental data and in making computations." Orig. art. has: 4 figures and 6 formulas.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors AN SSSR)

SUBMITTED: 30Aug63

DATE ACQ: 02Mar64

ENCL: 00

SUB CODE: OP,EC

NO REF Sov: 003

OTHER: 005

Card 2/2

ACCESSION NR: APL028433

S/0181/64/006/004/1078/1081

AUTHORS: Subashiyev, V. K.; Dubrovskiy, O. B.; Kukharskiy, A. A.

TITLE: Determining the optical constants and concentrations of free current carriers in strongly doped semiconducting materials by the reflection coefficient

SOURCE: Fizika tverdogo tela, v. 6, no. 4, 1964, 1078-1081

TOPIC TAGS: optical constant, current carrier, doped semiconductor, reflection coefficient

ABSTRACT: The authors describe a method of determining the indices of refraction, absorption, and concentration of free current carriers in semiconducting materials by the spectral behavior of the reflection coefficient of nonpolarized light at normal incidence. Beginning with the ordinary relations of reflection, refraction, and absorption for normal incidence, the authors express the effective part of the dielectric constant by refractive index and absorption coefficient. It follows the difference in dielectric constant (for pure and doped semiconductor) depends linearly on the square of the wavelength. A graph may be drawn of this dependence for standard samples with various carrier concentrations. The slope of this curve

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ACCESSION NR: AP4028433

is determined and extrapolated through a wide range of frequencies, thus extrapolating the values of dielectric constant. This permits determination of refractive index and absorption coefficient. Experimental tests were made on Si, and the indices of refraction and absorption were found to exhibit spectral dependence in the infrared region on the edge of intrinsic absorption. The authors conclude that the method proposed is especially effective for small, highly doped samples and also for rods with epitaxial films and p-n structures. A drop in refractive index is observed with decrease in wave length, and this is due to excitation of plasma vibrations in the electron gas. The natural frequencies of these vibrations are proportional to the square root of the carrier concentration. Thus, by determining the frequency from the behavior of the reflection coefficient (according to wavelength), the carrier concentration can be determined. Orig. art has: 4 figures and 9 formulas.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors AN SSSR)

SUBMITTED: 16Oct63 DATE ACQ: 27Apr64 ENCL: 00

Card 2/3

ACCESSION NR: AP4028433

SUB CODE: EC, SS

NO REV Sov: 003

OTHER: 009

Card 3/3

ACCESSION NR: AP4034905

S/0181/64/006/005/1303/1310

AUTHORS: Subashiyev, V. K.; Dubrovskiy, G. B.

TITLE: Indirect transitions and structure of the valence band of silicon

SOURCE: Fizika tverdogo tela, v. 6, no. 5, 1964, 1303-1310

TOPIC TAGS: valence band, silicon, SF 4 spectrophotometer, fundamental absorption, parabolic band

ABSTRACT: The authors have measured the absorption near the edge of the fundamental absorption band in homogeneous single crystals of silicon obtained from melts with concentrations of B and P ranging from  $10^{16}$  to  $2.2 \cdot 10^{19} \text{ cm}^{-3}$ . The spectral dependence of the absorption coefficient was measured for both n-type and p-type Si. It was found that the frequency dependence of free carriers in p-type Si follows the law  $\alpha \sim \nu^{-2}$ , as is true of most semiconductors. All investigated samples of n-type Si, in the range from 0.8 ev to the edge of fundamental absorption, exhibited a dependence of  $\alpha \sim \nu^{-m}$ , where  $m = 3.45 \pm 0.02$ . On the basis of a parabolic band, a deviation was found between the frequency dependence of fundamental absorption and the calculated absorption. If a variable effective mass is accepted for the

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ACCESSION NR: AP4034905

valence band of Si, depending on energy, the density of state in the nonparabolic band defined by this mass is equal to the density of state at the given energy in the parabolic band, with a mass equal to the variable mass at this point. As a first approximation, it may be said that the effective mass of the valence band in silica increases with energy only by change in the mass of light holes. "The authors thank B. Ya. Moyses for numerous useful discussions concerning this paper." Orig. art. has: 7 figures.

ASSOCIATION: Institut poluprovodnikov AN SSSR, Leningrad (Institute of Semiconductors AN SSSR)

SUBMITTED: 08Oct63

SUB CODE: 88

NO REP Sov: 004

ENCL: 00

OTHER: 010

Card 2/2

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

DUBROVSKIY, G.V.

Two-term approximation in the theory of slow collisions of heavy  
particles. Vest. LGU 18 no.10:16-23 '63. (MIRA 16:8)  
(Collisions (Nuclear physics))

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

ACCESSION NR: AP4041829

S/0054/64/000/002/0005/0010

AUTHOR: Dubrovskiy, G. V.

TITLE: Adiabatic approximation in the collision theory

SOURCE: Leningrad. Universitet. Vestnik. Seriya fiziki i khimii,  
no. 2, 1964, 5-10

TOPIC TAGS: collision theory, heavy particle, slow collision, adiabatic approximation, transition probability

ABSTRACT: Inelastic processes in slow collisions of heavy particles are usually described by adiabatic approximation. In a previous work (ZhTF 46, 861 (1964)), the author found the function characteristic of the probability of transitions for the case of two levels. In the present work, the fundamental matrix and the general solution of the vector equation for the interaction of h levels is constructed. The probabilities for nonadiabatic transitions are obtained from the phase integral method. The results are illustrated for the case of two pseudocrossing levels. "The author is grateful to Yu. D. Demkov and G.F. Drukarev for discussions." Orig. art. has: 2 figures and 34 equations

Card 1/2

ACCESSION NR: AP4041829

ASSOCIATION: None

SUBMITTED: 29Dec63

SUB CODE: NP

NR REF Sov: 004

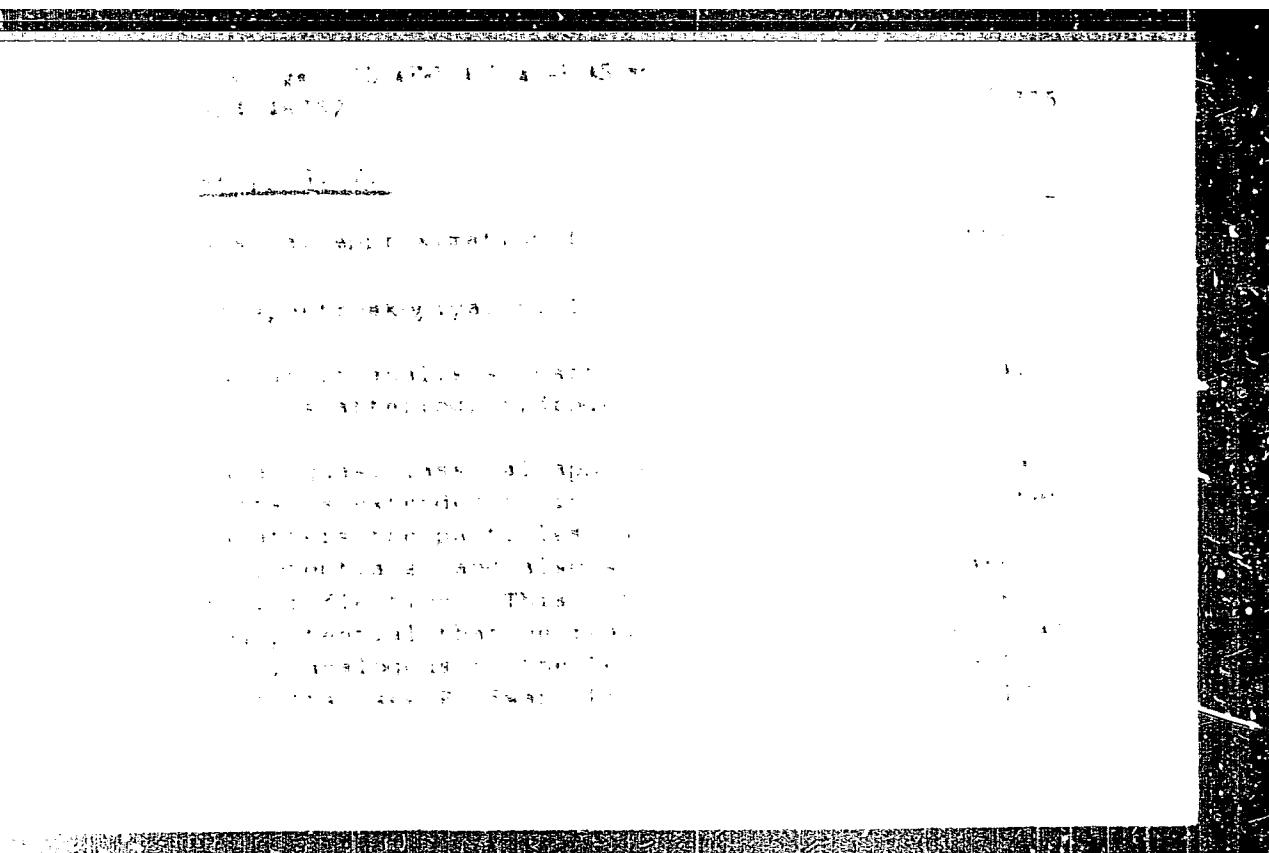
ENCL: 00

OTHER: 001

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"APPROVED FOR RELEASE: 08/25/2000

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APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

ACCESSION NR: AP4025919

6/0056/64/046/003/0863/0871

AUTHOR: Dubrovskiy, G. V.

TITLE: Nonadiabatic transitions in slow collisions between heavy particles

SOURCE: Zhurnal eksperimental'noy i teoretičeskoy fiziki, v. 46, no. 3, 1964, 863-871

TOPIC TAGS: nonadiabatic transition, heavy particle collision, slow collision, Landau-Zener theory, frequency dependence, analytic properties, parametric method, pseudointersection of levels, transition probability, frequency minimum, inelastic transition cross section, wave method, adiabatic solution, two term approximation, superbarrier reflection

ABSTRACT: In view of the strong dependence of the Landau-Zener theory and its various refinements on the analytic properties of the

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ACCESSION NR: AP4025919

interaction and the frequency, the author solves the parametric equations for slow collisions between heavy particles in the presence of a point of pseudointersection of the levels by expanding the solution in powers of the velocity of the colliding particles. The end purpose is to obtain formulas that are applicable to specific problems and are less dependent on the analytic properties of the interaction and the frequency. Asymptotic integration of the differential equation is used to determine the probability of the transitions in the presence of a frequency minimum, and a formula is derived which is a generalization of the presently known results on the theory of pseudointersection and is free of their shortcomings. The method is suitable for the investigation of the influence of other singularities of the interaction and of the frequency  $\omega$  on the cross sections of different inelastic transitions in the adiabatic region. The character of the obtained adiabatic solutions makes it possible to trace more fully the connection between the parametric method and the wave method to ascertain the degree to which the two-term ap-

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ACCESSION NR: AP4025919

proximation is connected with the problem of superbarrier reflection, and to determine the characteristic features of symmetrical resonance. "I take the opportunity to thank Yu. N. Demkov for a discussion of the work." Orig. art. has: 49 formulas.

ASSOCIATION: Leningradskiy gosudarstvennyy universitet' (Leningrad State University)

SUBMITTED: 01Jun63 DATE ACQ: 16Apr64 ENCL: 00

SUB CODE: PH NO REF Sov: 008 OTHER: 008

Card 3/3

ACCESSION NR: AP4043642

8/0056/64/047/002/0644/0648

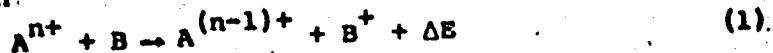
AUTHOR: Dubrovskiy, G. V.

TITLE: Charge exchange of multiply charged ions

SOURCE: Zh. eksper. i teor. fiz., v. 47, no. 2, 1964, 644-648

TOPIC TAGS: charge exchange, interaction cross section, ion transfer

ABSTRACT: The results previously obtained by the author (ZhETF, v. 46, 863, 1964) concerning the theory of pseudointersection of the potential-energy curve are used to derive more accurate formulas for the cross sections for the charge exchange of multiply charged ions in the reaction.



The derivation takes into account the dependence of the matrix elements on the energy.

Card 1/2

ACCESSION NR: AP4043642

ment of the interaction on the time and the fact that the terms do not diverge at infinity. Comparison with the experimental data shows good agreement between the theory and experiment over a wide interval of variation of the parameters of the problem. Some further possible developments of the theory are considered. "The author thanks Yu. P. Korostin and I. N. Gagarina for help with the numerical calculations, and academician V. A. Fok, Yu. N. Demkov, and G. F. Drukarev for a discussion of the work." Orig. art. has: 1 figure and 15 formulas.

ASSOCIATION: Leningradskiy gosudarstvennyy universitet (Leningrad State University)

SUBMITTED: 24Feb64

ENCL: 00

SUB CODE: NP

NR REF Sov: 008

OTHER: 007

Card 2/2

THEORY OF EARTHQUAKES WITH  
INVESTIGATION

McKersielet. Vastula, 1911.

— *Scutellaria* *lanceolata*, *lanceolata*

the indicated low levels of  
radioactive iodine were measured  
in the urine of the patients  
at the time of the first examination  
and again in the lower right  
extremity of the patient at  
the concluding time. The  
difference.

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

ENCL: 00

OTHER: ✓

DUBROVSKIY, G.V.; OB'yEDKOV, V.D.

Electron capture by alkali metal ions scattered on atoms of  
inert gases. Zhur.eksp. i teor.fiz. 49 no.6rl850-1857 D '65,  
(MIRA 1981)

1. Leningradskiy gosudarstvennyy universitet. Submitted June 21,  
1965.

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

ACC NR: AR0002727

SOURCE CODE: UR/00513/65/049/006/1850/1857

ORG: Leningrad State University (Leningradskiy gosudarstvennyy universitet)

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

ACC NR: AF5002727

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

ACC NR: AF6013485

UR/0120/66/000/002/0005/0012

AUTHOR: Dubrovskiy, I.A.

ORG: Moscow Engineering-Physical Institute (Moskovskiy inzhenerno-fizicheskiy institut)

TITLE: Wide band and pulse transistor amplifiers of the nanosecond range (a review)

SOURCE: Pribory i tekhnika eksperimenta; no. 2, 1966, 5-12

TOPIC TAGS: electronic amplifier, pulse amplifier, wide band amplifier, transistor amplifier, nanosecond range amplifier

ABSTRACT: The author reviews transistorized wide band and pulse amplifiers with an upper cutoff frequency over 100 megacycles, capable of high gain faithful amplification of pulses with a rise time of not over a few nanoseconds. Methods for enhancing amplifier gain are reviewed. An analysis of lumped parameter and of distributed amplification circuits follows. The capability of modern transistor circuits to attain wide band amplification without the complicated correction circuitry of tube amplifiers is noted. Orig. art. has: 13 figures, 2 formulas, 2 tables.

SUB CODE: O9

SUBM DATE: 10Jun65

ORIG REF: 012

OTH REP: 030

Card 1/1

UDC: 621.375.4

ACC NR: AP7001533

SOURCE CODE: UR/0108/66/021/012/0012/0018

AUTHOR: Dubrovskiy, I. A. (Active member of society)

ORG: Scientific and Technical Society of Radio Engineering and Electro-  
communication im. A. S. Popov (Nauchno-tehnicheskoye obshchestvo  
radiotekhniki i elektrosvyazi)

TITLE: High-frequency inductive compensation of tunnel-diode RC-amplifiers

SOURCE: Radiotekhnika, v. 21, no. 12, 1966, 12-18

TOPIC TAGS: tunnel diode, rf amplifier, electronic amplifier

ABSTRACT: A simple single-stage parallel-circuit tunnel-diode amplifier is used as an example demonstrating the efficiency of inductive compensation of the amplifier's frequency and transient characteristics. The compensating inductance is made up of stray inductances of the tunnel diode and associated connections. It

Card 1/2

UDC: 621.375.4

ACC NR: AP7001533

is found that: (1) The compensating inductance raises the upper cutoff frequency by 2-5 times without impairing the monotonous shape of the frequency characteristic; (2) Further increase of the inductance results in a humped characteristic with but a small (< 20%) cutoff frequency rise; (3) The compensating inductance shortens the front rise time to 1/2-1/4 without impairing the monotonous shape of the transient characteristic; (4) Further increase of the inductance, with a first spike of 10% or less, permits a further shortening of the rise time by 50%. An experimental verification involved two amplifiers designed with Soviet-made type-217 tunnel diodes operated at frequencies up to 17 Mc. "The author wishes to thank Engineer I. I. Shagurin for an experimental verification, and Technician R. Ya. Khusainova for plotting the curves." Orig. art. has: 5 figures, 30 formulas, and 4 tables.

SUB CODE: 09 / SUBM DATE: 30Nov64 / ORIG REF: 006

DUBROVSKIY, I.A.

Design of a two-stage pulse amplifier with complex  
feedback. Izv. vys. ucheb. zav.; radiotekh. 5  
no.3:381-387 My-Je '62. (MIRA 15:9)

1. Rekomendovana kafedroy elektroniki Moskovskogo  
inzhenerno-fizicheskogo instituta.  
(Amplifiers (Electronics))  
(Amplifiers, Electron tube)

ACCESSION NR: AP4042895

S/0108/64/019/007/0069/0075

AUTHOR: Dubrovskiy, I. A. (Active member)

TITLE: Nonlinearity of the output voltage waveshape in transistorized saw-toothed oscillators

SOURCE: Radiotekhnika, v. 19, no. 7, 1964, 69-75

TOPIC TAGS: transistor, transistorized oscillator, saw toothed oscillator

ABSTRACT: The effect of the operating mode of a transistor on its parameters and, further, on the linearity of the output voltage shape in saw-toothed oscillators is theoretically analyzed for these three oscillator types: (1) with a current-stabilizing transistor, (2) with an emitter repeater, and (3) with a capacitive feedback. These conclusions are offered: (1) Shortening the working period by reducing the capacitance of the main charge-discharge capacitor ( $C_0$ ) results in an essential impairment of the output voltage waveshape due to

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ACCESSION NR: AP4042895

nonlinear capacitances of the junctions; (2) To avoid the above phenomenon, the capacitance  $C_0$  should be selected from this inequality  $C_0 > (500+1000)(C_{el\alpha\alpha} + C_{m\alpha\alpha})$  for the current-stabilizing-transistor circuit or from  $C_0 > (500+1000)C_{el\alpha\alpha}$  for the two other schemes. "In conclusion, the author wishes to thank T. M. Agakhanian under whose guidance the project has been carried out." Orig. art. has: 7 figures and 18 formulas.

ASSOCIATION: Nauchno-tehnicheskoye obshchestvo radiotekhniki i elektrosvyazi  
(Scientific and Technical Society of Radio Engineering and Electrocommunication)

SUBMITTED: 05Jul62

ENCL: 00

SUB CODE: EO

NO REF SOV: 010

OTHER: 005

Card 2/2

UR AP5009618

UR/0106 64 470052  
621.375.4 11 11 11 11

Khrovskiy, I. A.; Shagurin, I. I.

ACTION OF THE GASES IN TUNNEL-DIODE SINGLE-STAGE AMPLIFIERS AT MEDIUM

VOL. 3, 1965, 47-52

amplifier, tunnel diode amplifier - series-circuit and parallel-circuit biasing. The effects of the following factors are investigated: The effects of the following factors are investigated: (a) positive- and negative-resistance characteristics; (b) temperature dependence; (c) negative-resistance characteristics due to the operating point when the bias-voltage is varied. The tunnel diode is used as an active two-pole network. The effect of the gases on the effect of the gases on the action of the tunnel diode is studied. These findings are relevant to the effect of the gases on the action of the tunnel diode.

VR AP500981B

(2)  $b'$  is higher for higher gains, and lower for lower ratios  $R_2/R_1$ , where  $R_1$  and  $R_2$  represent the input resistance of the first stage, the output resistance of the first stage, the input resistance of the second stage, and the output resistance of the second stage, respectively. (3) The series amplifier is recommended for low frequencies. (4) The parallel amplifier has a more gradual gain variation in the parallel amplifier connection. (5) Tunnel-diode amplifiers having a negative-resistance spread would have the same formulas.

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18 Dec 63

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OTHER: 001

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NK AP5004421

formulas are based on the nonlinearity of the characteristic which is a fundamental source of error. It is shown that the coefficient  $K_f$  shows that positive and negative feedback have advantages of this definition are illustrated by the example of analysis of a transistorized stage. Some experiments are given in section IV.5 related to prove the validity of the theory. The author wishes to thank L. P. Stepanov for his help in writing the work, V. A. Gakharyan for his valuable comments on the manuscript. " 2  
3 figures, 12 formulas, and 1 table.

DUBROVSKIY, I.F., inzh.

Some problems in the specialization of the repairing of  
machine tools and forging and pressing machines. Vest.  
mashinostro. 45 no.8:75-76 Ag '65.

(MIRA 18:12)

DUBROVA, P.P., kand. sel'khoz. nauk; DUBROVSKIY, I.I., red.; POPOV,  
V.N., tekhn. red.

[Manual for the fruit grower] Sputnik sadovoda. Tambov, Tambovskoe knishnoe izd-vo, 1960. 478 p.  
(Fruit culture) (MIRA 15:1)

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

DUBROVSKII, I.A.; SHAGURIN, I.I.

Instability of the amplification coefficient of single-stage  
tunnel diode amplifiers in the midfrequency region. *Elektronsvyaz'*,  
19 no.3:47-52 Mr '65. (MIR 18:5)

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

BAKHAREV, A.N., nauchnyy sotr.; DOBRINSKIY, N.Ya., nauchnyy sotr.;  
STEPANOV, P.A., nauchnyy sotr.; DUBROVSKIY, I.I., red.;  
RAGHKOV, P.A., tekhn. red.

[In the orchards and laboratories of Michurinsk] V sadakh i  
laboratoriakh Michurinska. Tambov, Tambovskoe knizhnoe izd-  
vo, 1961. 158 p.  
(MIRA 15:9)

1. Tsentral'naya geneticheskaya laboratoriya im. I.V.Michurina  
(for Bakharev, Dobrinskiy). 2. Nauchno-issledovatel'skiy in-  
stitut sadovodstva im. I.V.Michurina (for Stepanov).  
(Michurin, Ivan Vladimirovich, 1855-1935)  
(Michurinsk--Fruit culture--Research)

MATROSOV, Ivan Pavlovich; DUBOVSKIY, I.I., red.; POPOV, V.N.,  
tekhn. red.

[The time of great achievements] Vremia bol'shikh svershenii.  
Tambov, Tambovskoe knishnoe izd-vo, 1961. 25 p. (MIRA 16:3)

1. Predsedatel' kolkhoza "Udarnik" Morshanskogo rayona (for  
Matrosov).  
(Morshansk District--Collective farms--Management)

DUBROVSKIY, Ivan Ivanovich; CHERNYAK, R.I., red.; POPOV, V.N.,  
tekhn. red.

Mariia Dmitrievna Trunova. Tambov, Tambovskoe knishnoe izd-vo,  
(MIRA 16:3)  
1960. 28 p.  
(Trunova, Mariia Dmitrievna)  
(Peremaiskiy District (Tambov Province))—Stock and stockbreeding)

DUBROVSKIX, I.M.

On the theory of condensation, the critical point, and the meta-stable state. Ukr.fiz.shur. 7 no.7:724-732 Jl '62.

(MIRA 15:12)

(Condensation) (Critical point)

MARTYNOVA, O.I., doktor tekhn.nauk, prof.; KATKOVSKAYA, K.Ya., kand.tekhn.nauk;  
FEDOSEYCHUK, T.A., insh.; VAYNEYKIS, A.A., insh., dissertant;  
DUBROVSKIY, I.Ya., insh.

Transition of ammonia from water solutions to saturated steam.  
Teploenergetika 12 no.10:75-79 0 '65.

(MIRA 18:10)

1. Moskovskiy energeticheskiy institut.

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

DUBROVSKIY, I.Ya.

METRIK, B.A., inshener; MAKSYM, P.V., inshener; DUBROVSKIY, I.Ya.

Efficient scheme for supplying steam to plants of the  
rubber industry. Prez.energ. 12 no.9:15-17 S '57. (MIRA 10:10)  
(Steam engineering)

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

STYRIKOVICH, M.A.; MARTINOVА, O.I.; KATKOVSKAYA, K.Ya.; DUBROVSKIY, I.Ya.;  
MINCULINA, E.I.

Investigating the distribution of aluminum hydroxide in water and  
saturated water vapor. Atom. energ. 15 no.2:161-163 Ag '63.  
(MIRA 16:8)  
(Nuclear reactors) (Aluminum hydroxide)

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

STYRIKOVICH, M. A.; MARTYNNOVA, O. I.; KATKOVSKAYA, K. Ya.; DUBROVSKIY, I. Ya.;  
SMIRNOVA, I. N.

Transition of iodine from aqueous solutions into saturated steam.  
Atom. energ. 17 no.1:45-49 J1 '64. (MIRA 17:7)

DUBROVSKIY, I.Ye., kand. tekhn. nauk; MIGAI, V.K., kand. tekhn. nauk;  
NAZARENKO, V.S., inzh.

Method for the thermal calculation of regenerative air pre-heaters of boiler units. Energomashinostroenie 9 no. 3:47-48  
Mr'63.  
(MIRA 17:5)

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

APPROVED FOR RELEASE: 08/25/2000 CIA-RDP86-00513R000411420003-6"

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

ATTACHMENT: Perenba, V. A.; Vishnyak, Ya. S.; Dubrovskiy, V. N.

APPROVED FOR RELEASE: 08/25/2000

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"APPROVED FOR RELEASE: 08/25/2000

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"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

DUBROVSKIY, Konstantin Vladimirovich.

DUBROVSKIY, Konstantin Vladimirovich. V strane snegov i zolota. I Akutskaya Avtonomnaya Respublika, ee nastoyashchee, proshloe i budushchее. Moskva, Gosizdat, 1927. 48 p.

DLC: Unclassified

So: LC, Soviet Geography, Part II, 1951/Unclassified.

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

KWIGIN, P.I.; DUBROVSKIY, L.A.

Operation of silicon photocells in the case of large fluxes of  
solar energy. Izv. AN SSSR. Ser. fiz.-mat. nauk 6 no.3;  
39-44 '62. (MIRA 15:8)

1. Fiziko-tehnicheskiy institut AN USSR.  
(Photoelectric cells)

DUBROVSKIY, L.A.; KNIGIN, P.I.

Optimum operating conditions for silicon phototubes in case of  
large luminous fluxes. Izv. AN Uz. SSR. Ser. fiz.-mat. nauk 6  
no.4:57-61 '62. (MIRA 15:9)

1. Fiziko-tehnicheskiy institut AN UzSSR.  
(Photoelectric cells)

DUBROVSKIY, L.A.; MEL'NIK, V.G.; ODYNETS, L.L.

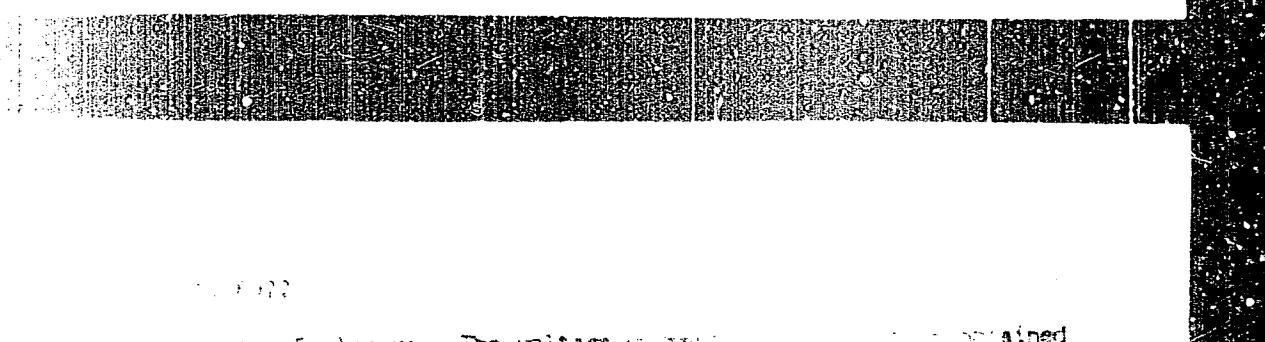
Anodic oxidation of silicon in pure water. Zhur.fiz.khim. 36  
no.10:2199-2204 O '62. (MIRA 17:4)

1. Petrozavodskiy gosudarstvennyy universitet.

... thin film diode structures  
and their current characteristics.

This work was undertaken because of the interest in the properties of the metal-insulator-semiconductor junctions in high-resistance films of various materials. As an element of theory of spark discharge it is believed that an investigation of the properties of such junctions can give information and is also of independent interest in the experiments with specially prepared film-type diodes, i.e., incorporating

a pressure of  $5 \times 10^{-5}$  mm Hg at a substrate temperature of 100°C. The con-  
ditions of evaporation in vacuum using Au, In, Al, and Sn. An assembly of  
two carbon lower electrode, prepared from the film, was used, as



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APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

24(5)

## AUTHORS:

Wang Kang-Ch'ang, Wang Hs'u-tseng, SOV/56-35-4-10/52  
Ting Ta-ts'so, Dubrovs'kiy, L. N., Kladnitskaya, Ye. N.,  
Solov'yev, M. I.

## TITLE:

Investigation of the Interaction of  $\pi^+$ -Mesons With Carbon  
at Energies of 250 - 270 MeV With the Help of a Propane Bubble  
Chamber (Isuchenije vzaimodejstviya  $\pi^+$ -mesonov s uglerodom pri  
energiyah 250 - 270 MeV s pomoshch'yu puzyr'kovoy propanovoy  
kamery)

## PERIODICAL:

Zhurnal eksperimental'noy i teoreticheskoy fiziki, 1958,  
Vol 35, Nr 4, pp 899-906 (USSR)

## ABSTRACT:

The interaction between pions and nuclei (especially C) has  
already been investigated by a number of papers for  $E_\pi < 200$  MeV  
(Refs 1-4) and for  $E_\pi > 200$  MeV (Refs 5-7) partly carried out  
by means of a cloud chamber and partly by means of scintillation  
counters. The authors of the present paper investigated the  
 $\pi^+$ -C-interaction in a propane bubble chamber, which was  
subjected to the action of a pion beam of the synchrocyclotron  
of the Ob'yedinennyj institut Yadernyh issledovanij (United  
Institute for Nuclear Research). The experimental arrangement

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Investigation of the Interaction of  $\pi^+$  Mesons ..... Sov/56-35-4-10/52  
With Carbon at Energies of 250 - 270 MeV With the Help of a Propane Bubble  
Chamber

is described and shown by figure 1 . Experimental results:  
1.) Elastic  $\pi^+$ -C scattering: for  $10^\circ \leq \theta \leq 70^\circ$  the cross section  
 $\sigma_{\text{elast.}} = (176 \pm 16) \text{mb}$  is obtained. For the scattering  
nucleus the absorption coefficient is  $K = 0.54 \cdot 10^{13} \text{cm}^{-1}$  and  
 $V = 30 \text{ MeV}$ ,  $R = 3.2 \cdot 10^{-13} \text{cm}$ . The dependence  $d\sigma/d\Omega(\theta)$  is  
shown (Fig 2). For  $45^\circ < \theta < 135^\circ$  (isotropic distribution)  
 $\sigma_{\text{elast.}} = (192 \pm 18.5) \text{mb}$ , which agrees well with the  
diffraction scattering cross section for the above V- and K-  
values. 2.) Inelastic  $\pi^+$ -D-scattering: Reaction:  $\pi^+ + C \rightarrow \pi^+ +$   
(N beams) ( $N=0, 1, 2, \dots, 6$ ),  $\sigma_{\text{inelast.}} = (120 \pm 18) \text{mb}$ .

A table shows the number of stars arranged according to the  
number of beams (separately for stars with and without mesons).

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Investigation of the Interaction of  $\pi^+$  Mesons                    SOV/56-35-4-10/52  
With Carbon at Energies of 250 - 270 MeV With the Help of a Propane Bubble  
Chamber

3.) Absorption of  $\pi^+$  mesons in carbon and charge exchange:  
For meson-free stars cross section  $\sigma = \sigma_a + \sigma_c - (165^{+34}_{-22}) \text{mb}$ ,  
where  $\sigma_a$  denotes the absorption cross section  $\sigma_c$ -charge  
exchange cross section. Table 2 shows the distribution of the  
number of beams in the stars for meson-free stars, in which  
connection experimental and theoretical data are compared;  
figure 5 shows the energy dependence of  $\sigma_a/\sigma_{\text{nucleus}}$  for pions.  
4.) Total inelastic cross section of  $\pi^+ - C$  interaction :  
 $\sigma_{\text{inelast}} = (296^{+38}_{-19}) \text{mb}$ . The authors finally thank Professor  
V. P. Dzhelepov who made it possible for them to work at the  
Laboratoriya yadernykh problem (Laboratory for Nuclear Problems),  
and they also expressed their gratitude to R. M. Sulyayev,  
Yu. A. Shcherbakov, A. I. Filippov, and L. B. Parfenov for  
their aid in carrying out experiments, and they also thank the

Card 3/4

Investigation of the Interaction of  $\pi^+$  Mesons                    SOV/56-35-4-10/52  
With Carbon at Energies of 250 - 270 MeV With the Help of a Propane Bubble  
Chamber

group of laboratory workers under the supervision of  
I, A. Ivanovskaya for their assistance in utilizing results.  
There are 5 figures, 2 tables, and 24 references, 12 of which  
are Soviet.

ASSOCIATION: Ob"yedinenyyi institut yadernykh issledovaniy  
(United Institute for Nuclear Research)

SUBMITTED: May 5, 1958

Card 4/4

ACCESSION NR: AT4031807

8/2914/62/000/079/0003/0031

AUTHOR: Dubrovskiy, M. I.; Chernyayev, R. N. (Candidate of technical sciences);  
Shchegolev, V. I.

TITLE: The harbor radar station "Raskat" harbor radar stations-a new aid to safe  
Investigation in harbor approaches.

SOURCE: Leningrad. Tsentral'nyy nauchno-issledovatel'skiy institut morskogo flota.  
Informatsionnyy sbornik, no. 79, 1962. Sudovozhdeniye i svyaz' (Navigation and com-  
munications), no. 20, 3-31

TOPIC TAGS: harbor radar, harbor radar station, radar, radar station, navigation aid,  
harbor approach, ship radar, navigation radar

ABSTRACT: The first experimental harbor radar station, "Raskat", was installed in  
Leningrad harbor in 1961. The location of the station and sector coverage (each on a  
separate display) of the 100-meter-wide open channel is shown in Figure 1 of the Enclo-  
sure. In the present paper, the basic radar parameters of "Raskat" are compared with  
the parameters of some harbor radars manufactured in Western Europe. The main sub-  
systems of "Raskat" are: 1) Antenna and waveguide system, including: a) parabolic  
cylinder dish with pancake feed; b) drive mechanism with motor and synchro system; c)  
waveguide system elements (phase shifter, measuring device for control of transmitter

Card 1/4

ACCESSION NR: AT4031807

parametors, ferrite valve-switch, bidirectional coupler, channel commutator, output power measuring device). 2) Transmitter system, consisting of two identical transmitters with magnetron oscillators, modulators and associated control circuits. 3) Receiver system, including: a) two identical receivers with RF amplifiers, AFC circuits, mixer sections, rectifiers, etc. (separate console); b) two sets of amplifiers with IF cascades (6 in each set) and detectors (separate console); c) two sets of sensitivity control circuits placed in the same console with transmitted power measuring device; d) system selector and interface circuits. 4) Display distribution panel. 5) Control console. 6) PPI with scales of 2, 5, 10 and 25 miles. Equipped with stationary and movable range markers and variable sweep. 7) Sector display indicator (A station can have up to 6 indicators) with maximum observation interval of 6.5 miles. 8) Generator of electronic markers of channel axis (360 markers, spaced at a minimum of 0.5 degrees in angle, angular stability 6', range stability 15 miles). 9) Main power panel. 10) Display system power panel. 11) Transmitter-receiver system power panel. 12) Power panel for UHF radio stations. 13) Voltage rectifier VSA-5. 14) Two power supplies ALA-7M. 15) Two voltage stabilizers SN-5. 16) Two UHF communication systems.

Cont

2/4

ACCESSION NR: AT4031807

A functional description of the main radar subsystems is given. The overall design is sufficiently flexible so that it could be installed in any harbor. Orig. art. has: 13 figures and 3 tables.

ASSOCIATION: Tsentral'nyy nauchno-issledovatel'skiy institut morskogo flota,  
Leningrad (Central Naval Scientific Research Institute)

SUBMITTED: 00

DATE ACQ: 06May64

ENCL: 01

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OTHER: 000

Card

3/4

ACCESSION NR: AT4031807

ENCLOSURE: 01

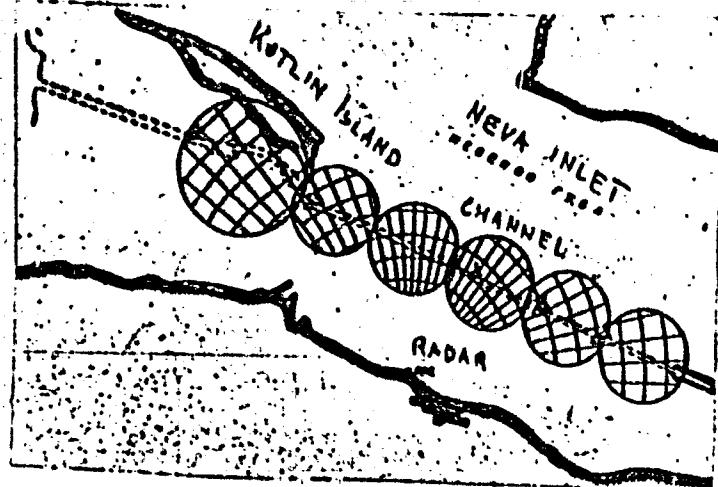


Fig. 1 - Approach to Leningrad Port and Radar Sector Coverage

Card 4/4

PALAGIN, A.; CHATSKIY, O.; ALEKSEYEV, A.; GLUZ, I.S.; ZABLOTSKIY, R.V.;  
DUBROVSKIY, M.A.

In honor of the 21st Congress of the CPSU. Kons. i ev. prem. 14  
no.1:4-7 Ja '59. (MIRA 12:1)

- 1.Direktor Odesskogo konservnogo kombinata (for Palagin).
- 2.Predsedatel' Odesskogo konservnogo zavedeskogo komiteta (for Chatskiy).
- 3.Direktor Kharabalinskogo konservnogo zaveda (for Alekseyev).
- 4.Glavnyy inzhener Tiraspol'skogo pleodokombinata (for Gluz).
- 5.Glavnyy inzhener Starodubetskogo oveschchesushil'nogo kombinata (for Zablotkiy).
- 6.Nachal'nik planovogo etdela Moskovskogo ordena Lenina Pishchevogo kombinata imeni Mikeyana (for Dubrovskiy).

(Canning.industry)

DUBROVSKIY, M.A.

Socialist competition between the enterprises of Moscow and of  
Leningrad. Kons. i ov. prom. 18 no.11:9-10 N '63. (MIRA 16:12)

1. Moskovskiy ordena Lenina Pishchevoy kombinat.

DUBOVSKY, M. B.

Res Inst of Epidemiol. and Microbiol., (-1944-)

Branch State Hospital for Children's Diseases. (-1944-).

"Experiment with Employment of Tartaric Acid in both Diphtheritic Patients and Healthy Bacilli - Carriers."

Zhur. Mikrobiol., Epidemiol., i Immunobiol., No. 6, 1944.

DUBROVSKIY, M.I., CHERNIAEV, R.N., kand.tekhn.nauk; SHCHEGOLEV, V.I.

Harbor radar station "Raskat." Inform. sbor. TSNIIMF no.79  
Sudovoah.i svias' no.20:3-31 '62. (MIRA 16:7)  
(Harbors--Equipment and supplies) (Radar in navigation)

NEZVETSKIY, G.V., kand.tekhn.nauk; DUBROVSKIY, M.V., inzh.; STEPANENKOV, I.  
Ye., inzh.

Sean welding of low-alloy 09G2 steels. Svar. proisv. no.12:35-  
36 D '61. (MIRA 14:12)

1. Bryanskij institut transportnogo mashinostroyeniya.  
(Steel alloys--Welding)

DUBROVSKIY, N.

Training workers and raising their qualifications. Mast. ugol. 4  
no. 3:5-6 Mr '55. (MIRA 8:6)

1. Nachal'nik otdela rabochikh kadrov Ministerstva ugol'noy  
promyshlennosti SSSR.  
(Mining engineering--Study and teaching)

DUBROVSKY, M.

Strengthen in every possible way socialist labor discipline.  
Mast.ugl. 6 no.5:15-16 My '57. (MERA 10:7)

1. Nachal'nik otdela rabochikh kadrov Ministerstva ugol'noy  
promyshlennosti SSSR.  
(Mine management)

DUFROVSKIY, N. A.

DUFROVSKIY, N. A. - "Seasonal Displacements of Certain Climatic Elements." Sub 13 Mar 52, Moscow State Pedagogical Inst imeni V. I. Lenin (Dissertation for the Degree of Candidate in Geographical Sciences).

SO: Vechernaya Moskva January-December 1952

DUBROVSKIY, Nikolay Alekseyevich; KOZLOV, M.V., redaktor; MNSTERGAZI,  
N.N., vsemirnyiy redaktor

[Geography lessons in class 8; work practice] Uroki po geografii  
v VIII klasse; iz opyta raboty. Moskva, Gos. uchebno-pedagog. izd-  
vo Ministerstva prosveshcheniya RSFSR, 1955. 42 p. (MIRA 8:7)  
(Geography--Study and teaching)

BORYCHEV, Nikolay Ivanovich; ZAV'YALOV, Pavel Fedorovich; DUBROVSKII,  
N.D., ovt.red.; OSVAL'D, N.Ye., red.izd-va; BRESLAVSKAYA, L.Sh.,  
tekhn.red.

[Work and relaxation of miners in the U.S.S.R.] Trud i otdykh  
shahterov v SSSR. Moskva, Gos.nauchno-tekhn.izd-vo lit-ry po  
gornomu delu, 1960. 53 p. (MIRA 1):12)  
(Miners) (Hours of labor)

DUBROVSKII, N. M.

Use of water soluble styrene butadiene paints. Transp, stroi.  
13 no.3:55 Mr '63. (MIRA 16:4)

1. Instruktor peredovykh metodov truda Tashkentskoy nauchno-  
issledovatel'skoy stantsii Orgtransstroya.

(Painting, Industrial)

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CIA-RDP86-00513R000411420003-6

DUBROVSKIY, N.M., inzh.; MESHTA, G.F., inzh.

Lashing of the wires of an overhead power transmission line. Elek.  
sta. 34 no.8:76-78 Ag '63. (MIRA 16:11)

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

GERSHANOV, S.V.; DUBROVSKIY, Nikolay Petrovich

[Corn cultivation with over-all mechanization] Vozdelyvanie  
kukuruzy pri kompleksnoi mekhanizatsii. Moskva, Gos.izd-vo  
selkhoz.lit-ry, 1958. 109 p.  
(Corn (Maize))  
(MIRA 12:3)

CHALISHEV, Aleksandr Matveyevich [deceased]; DUBROVSKII, M.E., inshcher,  
nauchnyy redaktor; KUNITS, A.P., redaktor Izdatel'stva; TOLK, A.N.,  
tekhnicheskiy redaktor

[Drilling bore holes for water supply] Ustroistvo burevykh skvashin  
dlia vodosnabzheniia. Moskva, Gos. izd-vo lit-ry po stroit. i  
arkhitektur, 1956. 194 p.  
(Water, Underground) (Boring)

DUBROVSKIY, N. V.

14-57-6-12747

Translation from: Referativnyy zhurnal, Geografiya, 1957, Nr 6,  
p 136 (USSR)

AUTHOR: Dubrovskiy, N. V.

TITLE: Zoobenthos in Fish Ponds on the Collective Farm Imeni  
Stalin in the Bogodukhov Rayon .. (Zoobentos rybovod-  
nykh prudov kolkhoza im. Stalina Bogodukhovskogo  
rayona)

PERIODICAL: Uch. zap. Khar'kovsk. un-ta, 1956, Vol 67, pp 153-155

ABSTRACT: The author presents a list of bottom-dwelling species  
in three ponds. The main, according to numbers and  
bulk, are the oligochaeta and the chironomid larvae.  
The biomass of zoobenthos is considerably greater in  
April and May than it is in summer months. This can  
be explained by the fact that carp, feeding on  
zoobenthos, destroy much of it.

I. B.

Card 1/1

OSIPOV, K.I.; DUBROVSKIY, N.V., zaschishennyj uchitel' shkoly RSFSR

Practice of rural schools in uniting academic instruction with  
agricultural work of students. Biol. v. shkole no.2:42-46 Mr-dp '61.  
(MIRA 14:3)

1. Penzenskiy peda-gogicheskiy institut (for Osipov). 2. Direktor  
Sosedskoy sredney shkoly (for Dubrovskiy).  
(Agriculture—Study and teaching)  
(Society—Education, Cooperative)

USSR

S/0286/64/000/004/0037/0037

ACCESSION NR: AP4021226

AUTHOR: Bel'kevich, P. I.; Gayduk, N. A.; Dubrovskiy, N. V.; Yakobson, B. V.; Lamm, B. A.; Faydal', Il Ya.; Sokolov, A. D.

TITLE: A method for producing extrusion materials. Class 39, No. 160583

SOURCE: Byul. izobret. i tovarn. znakov, no. 4, 1964, 37

TOPIC TAGS: plastic, resin, phenolformaldehyde resin, peat, extrusion material, molding material

ABSTRACT: This authorship certificate introduces a method for producing molding materials based on phenolformaldehyde resins with peat as a filler. In order to raise the quality of the plastic, the peat is subjected to preliminary heat treatment. 2. A method on this same system in which the heat treatment of the peat is carried out at 200-250°C in a vacuum or in an inert gas vehicle. 3. A method on this same system in which wood flour goes into the composition of the extrusion materials.

ASSOCIATION: none

Card: 1/2

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ACCESSION NR: AF4021226

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ENCL: 00

SUB CODE: XA

NO REF Sov: 000

OTHER: 000

Card 2/2

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"

DUBROVSKIY, Nikolay Vasil'yevich; VANCHUK, L., red.

[How to set up antennas for long-distance television reception] Kak ustroit' antenny dlia dal'nego priema televideniya. Minsk, Belarus', 1965. 56 p.  
(MIRA 18:4)

"APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6

DUBROVSKII, O. V.

DUBROVSKII, O. V.- "Investigation of the Aerodynamics of Two-Register Combustion Chambers in Gas-Turbine Installations." Leningrad Shipbuilding Inst, Leningrad, 1955  
(Dissertations For Degree of Candidate of Technical Sciences)

SO: Knizhnaya Letopis' No. 26, June 1955, Moscow

APPROVED FOR RELEASE: 08/25/2000

CIA-RDP86-00513R000411420003-6"